

Notice of References Cited	Application/Control No. 10/731,722	Applicant(s)/Patent Under Reexamination TRAN ET AL.	
	Examiner David Sample	Art Unit 1755	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,689,709	02-2004	Tran et al.	502/65
*	C	US-2004/0242938	12-2004	Kanougi et al.	568/715
*	D	US-5,143,876	09-1992	Chang et al.	502/64
*	E	US-5,102,839	04-1992	Borghard et al.	502/66
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	M	US-			

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NON-PATENT DOCUMENTS

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	U	Mohamed et al., "Redox Behavior of Copper Mordenite Zeolite," JOURNAL OF MATERIALS SCIENCE, 30 (1995) 4834-4838.
	V	Cambor et al., "Characterization of nanocrystalline zeolite Beta," MICROPOROUS AND MESOPOROUS MATERIALS, 25 (1998) 59-74.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.